Nodal integration finite element techniques for analysis of piezoelectric solids

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Abstract

A stabilized conforming nodal integration (SCNI) method is presented to formulate two efficient smoothing piezoelectric elements for static analysis of planar piezoelectric structures with quadrilateral mesh. The approximations of mechanical strains and electric potential fields are normalized by the smoothing constant function of the SCNI technique over each smoothing cell. This method allows field gradients to be directly computed from interpolating shape functions using boundary integrations along each edge of the smoothing element. The boundary integration will contribute to the preservation of high accuracy of the method even when elements are extremely distorted, for example, a concave quadrilateral. No mapping or coordinate transformation and derivatives of shape functions are necessary so that the original meshes with badly shaped elements can be used. The present elements do not introduce any additional degrees of freedom and are easy to implement into an existing finite element method (FEM). Numerical examples and comparative studies with analytic solutions are presented to demonstrate the simplicity, efficiency and accuracy of the elements.

Key Words: Piezoelectric structures, Nodal integration finite element method, Electro-mechanics.

1. Introduction

Piezoelectric materials have many applications in various modern engineering fields such as smart structures, mechatronics, or micro-electromechanical system (MEMS) technology. It is evident that they have attracted significant attention of researchers. Great progress have been made over past decades towards better understanding of electromechanical coupling behaviour of piezoelectric materials using analytic/numerical methods and experimental models. Since the work of Allik and Hughes (1970) using FEM to analyze the vibration of piezoelectric media, the literature on piezoelectric FEM has been developed extensively and is too large to list here. More details and reviews on the development of the FEM for piezoelectric materials and smart structures can be found in Mackerle (2003).

Although the FEM solution is quite effective and versatile, its performance is highly mesh-dependent and badly deteriorates when mesh distortion occurs. On the other hand, several mesh-free methods have become an alternative approach for analysis of piezoelectric material such as the Point Interpolation Meshfree (PIM) method of Liu et al. (2002), the Radial Point Interpolation Meshfree (RIPM) method of Liu et al. (2003), the Point Collocation Meshfree (PCM) method of Ohs and Aluru (2001), the Meshless Local Petrov-Galerkin (MLPG) method of Sladek et al. (2006), etc. A recent meshless technique is the stabilized conforming nodal integration (SCNI) mesh-free method (Chen et al. 2001). The application of the SCNI in the FEM was first proposed by Liu et al. (2007a, b), Dai et al. (2007a, b) for 2D elasticity. It is found that the FEM, integrated with the SCNI technique, achieves more accurate results as compared with the conventional one without increasing the modelling and computational costs. Following the works of Liu et al., the
application of the SCNI in the FEM has been further developed for the analysis of coupling between mechanical and electrical behaviours of 2D piezoelectricity structures by Nguyen-Van et al. (2008a, b, c). A family of simple, accurate and efficient planar low-order piezoelectric elements have been successfully developed by the present authors.

In this paper, two types of the developed elements are introduced and summarized for static analysis of piezoelectric solids.

2. Review of finite element formulations for 2D piezoelectric problems

The mechanical constitutive relation for 2D piezoelectric materials can be expressed in the $e$–form as follows.

$$\sigma = c_{ee} \varepsilon - e^T E,$$  \hspace{1cm} (1)

$$D = e \varepsilon + g E,$$  \hspace{1cm} (2)

where $c_{ee}$ is the plane elastic stiffness matrix, $e$ is the plane piezoelectric matrix and $g$ is the plane dielectric constant matrix.

Equations (1)–(2) can be rewritten in the explicit form in the $x$–$z$ plane as

$$\begin{bmatrix} \sigma_x \\ \sigma_z \\ e_x \\ e_z \end{bmatrix} = \begin{bmatrix} c_{11} & c_{13} & 0 \\ c_{13} & c_{33} & 0 \\ 0 & 0 & c_{55} \end{bmatrix} \begin{bmatrix} \varepsilon_x \\ \varepsilon_z \\ e_{15} \end{bmatrix} - \begin{bmatrix} 0 \\ 0 \\ e_{31} \end{bmatrix} E_z,$$  \hspace{1cm} (3)

$$\begin{bmatrix} D_x \\ D_z \end{bmatrix} = \begin{bmatrix} 0 & 0 & e_{15} \\ e_{31} & e_{33} & 0 \\ 0 & 0 \end{bmatrix} \begin{bmatrix} \varepsilon_x \\ \varepsilon_z \\ e_{15} \end{bmatrix} + \begin{bmatrix} g_{11} & 0 \\ 0 & g_{33} \end{bmatrix} \begin{bmatrix} E_x \\ E_z \end{bmatrix}.$$  \hspace{1cm} (4)

The finite element approximation solution for 2D piezoelectric problems using the standard linear element can be expressed as

$$\mathbf{u} = \sum_{i=1}^{np} N_i \mathbf{q}_i = \mathbf{N}_u \mathbf{q},$$  \hspace{1cm} (5)

$$\mathbf{\phi} = \sum_{i=1}^{np} N_i \mathbf{\phi}_i = \mathbf{N}_\phi \mathbf{\phi},$$  \hspace{1cm} (6)

where $np$ is the number of nodes of an element; $\mathbf{q}$, $\mathbf{\phi}$ are the nodal displacement and nodal electric potential vectors and $\mathbf{N}_u$, $\mathbf{N}_\phi$ are shape function matrices.

The corresponding approximation of the linear strain $e$ and electric field $E$ are

$$\varepsilon = \nabla \cdot \mathbf{u} = \mathbf{B}_u \mathbf{q},$$  \hspace{1cm} (7)

$$\mathbf{E} = -\nabla \mathbf{\phi} = -\mathbf{B}_\phi \mathbf{\phi},$$  \hspace{1cm} (8)

where

$$\mathbf{B}_u^T = \begin{bmatrix} N_{i,x} \\ 0 \\ 0 \end{bmatrix}, \quad \mathbf{B}_\phi^T = \begin{bmatrix} N_{i,x} \\ N_{i,z} \end{bmatrix}.$$  \hspace{1cm} (9)

By taking the Hamilton’s principle, the piezoelectric dynamic equations of an element can be obtained as follows.
\[
\begin{bmatrix}
M_{uu} & 0 & \mathbf{q} \\
0 & 0 & \mathbf{\phi}
\end{bmatrix}
\begin{bmatrix}
K_{uu}^e & K_{up}^e & \mathbf{q} \\
K_{up}^e & K_{pp}^e & \mathbf{\phi}
\end{bmatrix}
\begin{bmatrix}
\mathbf{q} \\
\mathbf{\phi}
\end{bmatrix}
= \begin{bmatrix}
\mathbf{F} \\
\mathbf{Q}
\end{bmatrix},
\]

(10)

in which
\[
M_{uu} = \int_{\Omega} \rho N_u^T N_u d\Omega,
\]
(11)
\[
K_{uu}^e = \int_{\Omega} B_u^T \epsilon^e B_u d\Omega,
\]
(12)
\[
K_{up}^e = \int_{\Omega} B_u^T \epsilon^e B_p d\Omega,
\]
(13)
\[
K_{pp}^e = -\int_{\Omega} B_p^T \sigma B_p d\Omega,
\]
(14)
\[
F = \int_{\Omega} N_u^T f d\Omega + \int_{\Gamma} N_u^T t d\Gamma, \quad Q = \int_{\Gamma} N_p^T \mathbf{q} d\Gamma.
\]
(15)

For static analysis (\( \mathbf{\dot{q}} = 0 \)), Equation (10) is reduced to
\[
\begin{bmatrix}
K_{uu}^e & K_{up}^e \\
K_{up}^e & K_{pp}^e
\end{bmatrix}
\begin{bmatrix}
\mathbf{q} \\
\mathbf{\phi}
\end{bmatrix}
= \begin{bmatrix}
\mathbf{F} \\
\mathbf{Q}
\end{bmatrix}.
\]
(16)

3. Nodal integration techniques for piezoelectric finite element method

In the SCNI technique, the strain (\( \varepsilon \)) and the electric (\( \mathbf{E} \)) field used to evaluate the stiffness matrix is computed by a weighted average of the standard strain and electric field of the finite element method. In particular, at an arbitrary point \( x^k \) in a smoothing element domain \( \Omega^k \), they are approximated as follows.
\[
\varepsilon^k (x^k) = \int_{\Omega^k} \varepsilon(x) \Phi^k (x-x^k) d\Omega,
\]
(17)
\[
\mathbf{E}^k (x^k) = \int_{\Omega^k} \mathbf{E}(x) \Phi^k (x-x^k) d\Omega,
\]
(18)

where \( \Phi^k \) is a smoothing function that is here chosen as a constant function
\[
\Phi^k (x-x^k) = \begin{cases} 
1/ A^k & x \in \Omega^k \\
0 & x \notin \Omega^k
\end{cases}
\]
(19)
in which \( A^k = \int_{\Omega^k} d\Omega \) is the area of the smoothing cell \( \Omega^k \).

Two schemes are proposed to transform original finite elements into smoothing domains \( \Omega^k \) (smoothing elements) in which the smoothing operation of the SCNI is performed. The first scheme forms the so-called cell-based element approach and the second the node-based element approach. The two approaches are illustrated in detail in Figure 1.

Substituting \( \Phi^k \) into Equation (17) – (18) and applying the divergence theorem, we obtain a smoothed strain and smoothed electric field in the domain \( \Omega^k \) as
\[
\varepsilon^k (x^k) = \frac{1}{A^k} \int_{\Omega^k} \nabla \cdot \mathbf{u}(x) d\Omega = \frac{1}{A^k} \int_{\Gamma} n_a^s u(x) d\Gamma,
\]
(20)
\[
\mathbf{E}^k (x^k) = -\frac{1}{A^k} \int_{\Omega^k} \nabla \cdot \mathbf{\Phi}(x) d\Omega = -\frac{1}{A^k} \int_{\Gamma} n_a^p \mathbf{\Phi}(x) d\Gamma,
\]
(21)
where \( n_k^i \) and \( n_k^p \) are matrices associated with unit outward normal to the boundary \( \Gamma^k \),

\[
\begin{pmatrix}
1 & 0 \\
0 & n_k^i \\
n_k^p^i & n_k^p^p
\end{pmatrix}, \quad \begin{pmatrix}
n_k^i \\
n_k^p
\end{pmatrix},
\]

(22)

and \( u(x), \phi(x) \) are approximated function as in Equation (5) – (6).

By introducing the finite element approximation of \( u \) and \( \phi \), Equation (20)–(21) can be transformed in the matrix form as follows.

\[
\begin{pmatrix}
\tilde{u}^i(x^i) \\
\tilde{\phi}^i(x^i)
\end{pmatrix} = \sum_{i=1}^{nk} \begin{pmatrix}
\tilde{B}_u^i(x^i) \\
\tilde{B}_\phi^i(x^i)
\end{pmatrix} q_i ,
\]

(23)

\[
\tilde{E}^i(x^i) = -\sum_{i=1}^{nk} \begin{pmatrix}
\tilde{B}_u^i(x^i) \\
\tilde{B}_\phi^i(x^i)
\end{pmatrix} \phi ,
\]

(24)

where \( nk \) is the number of nodes connecting directly to node \( k \) (node-based element approach) or the number of subcells (cell-based element approach),

\[
\tilde{B}_u^i(x^i) = \frac{1}{A^i} \int_{\Gamma^i} \begin{bmatrix}
N_n^i n_z^i & 0 \\
0 & N_n^i n_z^i \\
N_i^i n_z^i & N_i^i n_z^i
\end{bmatrix} d\Gamma^i ,
\]

(25)

\[
\tilde{B}_\phi^i(x^i) = \frac{1}{A^i} \int_{\Gamma^i} \begin{bmatrix}
N_i^i n_z^i \\
N_i^i n_z^i
\end{bmatrix} d\Gamma^i .
\]

(26)

When bilinear quadrilateral elements are used for modelling, a linear completed displacement field along the boundary \( \Gamma^k \) is guaranteed. Therefore, one Gaussian point is sufficient for accurate boundary integration along each line segment \( \Gamma_i^k \) of the contour \( \Gamma^k \) of the domain \( \Omega^k \), and Equations (25) – (26) can be evaluated as

\[
\tilde{B}_u = \frac{1}{A^k} \sum_{b=1}^{nk} \begin{bmatrix}
N_i(x_b^G) n_z^k \\
0 \\
N_i(x_b^G) n_z^k
\end{bmatrix} \begin{bmatrix}
n_z^k \\
n_z^k
\end{bmatrix} ,
\]

(27)
\[
\tilde{B}_\rho = \frac{1}{A^k} \sum_{b=1}^{nb} \left[ N_i(x_b^G) n_b^k \right] \tilde{B}_b^k,
\]
where \( nb \) is the total number of the line segments of the contour \( \Gamma_k \), \( x_b^G \) is the midpoint (Gauss point) of each line segment \( \Gamma_b^k \), whose length and outward unit normal are \( l_b^k \) and \( n_b^k \), respectively.

Finally, the element stiffness matrices in Equations (12) – (14) can be rewritten as follows.

\[
\tilde{K}^{kk}_{uu} = \sum_{i=1}^{nk} \tilde{B}_u^T e_k \tilde{B}_u A^k
\]  
(29)

\[
\tilde{K}^{kk}_{p \phi} = \sum_{i=1}^{nk} \tilde{B}_u^T e^{\phi} \tilde{B}_\phi A^k
\]  
(30)

\[
\tilde{K}^{kk}_{p \phi} = -\sum_{i=1}^{nk} \tilde{B}_\phi^T e^{\phi} \tilde{B}_\phi A^k
\]  
(31)

4. Numerical examples

In this section, two examples are employed to demonstrate and assess the performance of two smoothing elements as applied to the linear static analysis of two-dimensional piezoelectric structures. The node-based smoothing piezoelectric element is denoted as NSPE-Q4 and the cell-based one as SPE-Q4.

A piezoelectric (PZT-5) strip, polarized in the z-direction, under a combined loading of pressure and applied voltage is analyzed (Figure 2). Two types of combined loads corresponding to shear and bending behaviour are considered, respectively. The material PZT-5 is used for the problems and its properties are

\[
s_{11} = 16.4 \times 10^{-6}, \quad s_{13} = -7.22 \times 10^{-6}, \quad s_{33} = 18.8 \times 10^{-6}, \quad s_{55} = 47.5 \times 10^{-6}(m m^2 / N)
\]

\[
d_{31} = -172 \times 10^{-9}, \quad d_{33} = 374 \times 10^{-9}, \quad d_{33} = 584 \times 10^{-9} (m m / V)
\]

\[
g_{11} = 1.53105 \times 10^{-8}, \quad g_{33} = 1.505 \times 10^{-7} (N/V^2)
\]

![Figure 2. A piezo-strip under different combined loads: (a) shear deformation and (b) bending deformation.](image)

The boundary conditions for the piezo-strip in shear are

\[
\phi_z(x, \pm h) = 0, \quad \sigma_z(x, \pm h) = \sigma_0, \quad \tau_{xz}(L, z) = 0, \quad \tau_{zx}(x, \pm h) = 0, \quad \phi(L, yz) = -V_0,
\]

\[
\sigma_z(L, z) = 0, \quad \phi(0, z) = +V_0, \quad u(0, z) = 0, \quad w(0, 0) = 0.
\]

and the boundary conditions for the piezo-strip in bending deformation are
\( \phi(x, \pm h) = \pm V_0 \), \( \sigma_z(x, \pm h) = 0 \), \( \tau_{xz}(x, \pm h) = 0 \), \( \phi_z(L, z) = 0 \), \( \sigma_z(L, z) = \sigma_0 + \sigma_i z \), \\
\( \tau_{xz}(L, z) = 0 \), \( \phi_z(0, z) = 0 \), \( u(0, z) = 0 \), \( w(0, 0) = 0 \).

The analytic solutions for these problems can be found in Gaudinzi and Bathe (1995). In the calculation, we set \( L = 2h = 1 \) mm, \( \sigma_0 = -5 \) N/mm\(^2\), \( \sigma_i = 20 \) N/mm\(^2\) and \( V_0 = 1000V \).

Two meshes, one with 8\( \times \)8 uniform elements and the other with 8\( \times \)8 distorted elements, are considered in this analysis as shown in Figure 3.

Figure 3. Typical meshes of a piezo-strip: (a) regular elements and (b) irregular elements.

All the numerical results of the piezo-strip in shear are compared with corresponding analytic solutions and plotted together in Figures 4 – 6.

Figure 4. A piezo-strip in shear: (a) u-displacement distribution, (b) u-displacement error.

Figure 5. A piezo-strip in shear: (a) w-displacement distribution, (b) w-displacement error.
It can be seen that all the computed displacements and electric potentials for both meshes and for both elements are in good agreement with analytic solutions.

For a uniform mesh, it is observed that the performance of SPE-Q4 element and NSPE-Q4 element achieves similar predictions. However, for the distorted mesh, the accuracy of SPE-Q4 for displacements is better than that of the NSPE-4 as can be seen from Figure 4b–5b.

Figure 6. A piezo-strip in shear: (a) $\phi$-electric potential, (b) $\phi$-electric potential error.

Figure 7. A piezo-strip in bending: (a) $u$-displacement distribution, (b) $u$-displacement error.

Figure 8. A piezo-strip in bending: (a) $w$-displacement distribution, (b) $w$-displacement error.
The numerical results for the piezo-strip in bending are illustrated in Figure 7–9. As can be seen, both computed displacements and electric potential match well the exact solutions for SPE-Q4 element as well as NSPE-Q4 element.

Once again, the SPE-Q4 element demonstrates better performance with respect to displacement fields than that of the NSPE-Q4 for the distorted mesh. For the uniform mesh, both elements perform nearly equally well.

Figure 9. A piezo-strip in bending: (a) φ-electric potential, (b) φ-electric potential error.

5. Conclusions

Two efficient piezoelectric elements based on nodal integration finite element techniques are developed and presented for linear static analysis of 2D piezoelectric solids. Numerical solutions are verified by excellent agreement with analytic solutions. Particularly, the present method can yield accurate results even with extremely distorted meshes.

6. References


